

Substitute Form PTO-1449 (Modified)		U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 07977/263001/US4563	Application No. Unknown
<b>Information Disclosure Statement</b> by Applicant (Use several sheets if necessary) (37 CFR §1.98(b))		Applicant Yamazaki, et al.		
		Filing Date Filed Herewith	Group Art Unit	

09/79 U.S. PRO  
09/760499  
01/11/01

U.S. Patent Documents							
Examiner Initial	Desig. ID	Patent Number	Issue Date	Patentee	Class	Subclass	Filing Date If Appropriate
qz	AA	5,757,456	5/26/98	Yamazaki, et al.	—	—	
1	AB	5,821,138	10/13/98	Yamazaki, et al.	—	—	
1	AC	5,834,327	11/10/98	Yamazaki, et al.	—	—	
qz	AD	6,118,502	9/12/00	Yamazaki, et al.	—	—	
	AE						
	AF						
	AG						

#### Foreign Patent Documents or Published Foreign Patent Applications

Examiner Initial...	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation <input checked="" type="checkbox"/> Yes <input type="checkbox"/> No
qz	AH	8-96959	4/12/96	Japan	—	—	Abstract only
1	AI	9-63770	3/7/97	Japan	—	—	Abstract only
1	AJ	9-312260	12/2/97	Japan	—	—	Abstract only
1	AK	10-247735	9/14/98	Japan	—	—	Abstract only
1	AL	10-270363	10/9/98	Japan	—	—	Abstract only
1	AM	11-191628	7/13/99	Japan	—	—	Abstract only
1	AN	8-254686	10/1/96	Japan	—	—	Abstract only
qz	AO	8-288522	11/1/96	Japan	—	—	Abstract only

#### Other Documents (include Author, Title, Date, and Place of Publication)

Examiner Initial	Desig. ID	Document
qz	AP	Shimoda, et al., "Surface Free Technology by Laser Annealing (SUFTLA)", IEDM Technical Digest, 1999, pp.289-292.
	AQ	
	AR	
	AS	

Examiner Signature <i>John A. N.</i>	Date Considered 2/24/03
EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	